

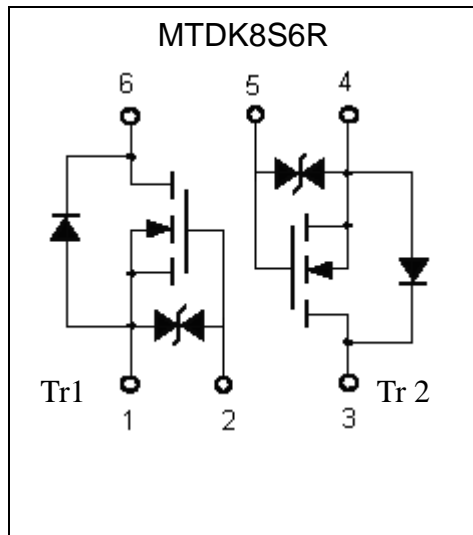
N-CHANNEL MOSFET (dual transistors)

MTDK8S6R

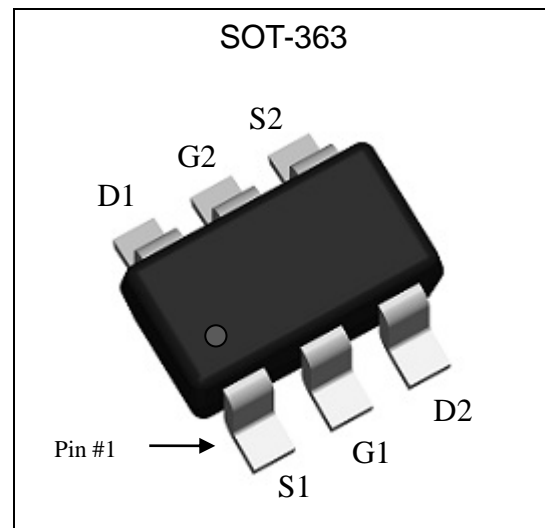
Description

- ESD protected gate, $\geq 2\text{kV}$ (HBM)
- High speed switching
- Easily designed drive circuits
- Easy to use in parallel
- Pb-free lead plating and halogen-free package

Symbol

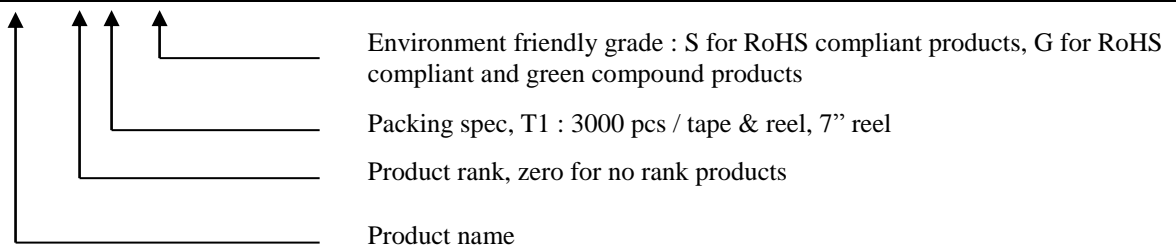


Outline



Ordering Information

Device	Package	Shipping
MTDK8S6R-0-T1-G	SOT-363 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel





The following characteristics apply to both Tr1 and Tr2
Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	BV _{DSS}	30	V
Gate-Source Voltage	V _{GS}	±20	
Continuous Drain Current @ V _{GS} =10V, T _A =25°C (Note 3)	I _D	480	mA
Continuous Drain Current @ V _{GS} =10V, T _A =70°C (Note 3)		384	
Pulsed Drain Current (Notes 1, 2)	I _{DM}	1900	
Total Power Dissipation (Note 3)	P _D	300	mW
ESD susceptibility (Note 4)	V _{ESD}	2000	V
Operating Junction Temperature Range	T _j	-55~+150	°C
Storage Temperature Range	T _{stg}	-55~+150	°C

Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal resistance, Junction-to-Ambient , max (Note 3)	R _{θJA}	417	°C/W
Thermal resistance, Junction-to-Case , max	R _{θJC}	150	

- Note : 1. Pulse width limited by maximum junction temperature.
 2. Pulse Width ≤ 300μs, Duty cycle ≤ 2%.
 3. Surface mounted on copper pad of FR-4 board with minimum footprint, 2 oz. copper.
 4. Human body model, 1.5kΩ in series with 100pF

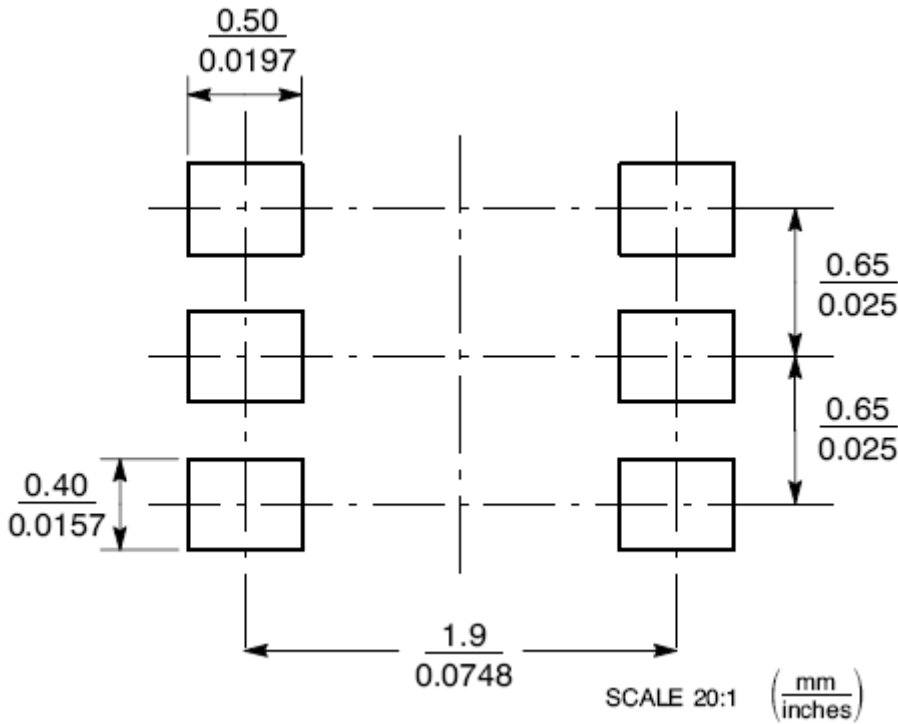
Electrical Characteristics (Ta=25°C)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS} *	30	-	-	V	V _{GS} =0V, I _D =10μA
ΔBV _{DSS} /ΔT _j	-	25	-	mV/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	0.7	-	1.6	V	V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±10	μA	V _{GS} =±16V, V _{DS} =0V
I _{DSS}	-	-	1		V _{DS} =24V, V _{GS} =0V
	-	-	10		V _{DS} =24V, V _{GS} =0V (T _j =70°C)
R _{DS(ON)}	-	0.38	0.8	Ω	V _{GS} =10V, I _D =500mA
	-	0.44	1.3		V _{GS} =4.5V, I _D =200mA
	-	0.63	3		V _{GS} =2.5V, I _D =10mA
G _{FS}	100	370	-	mS	V _{DS} =5V, I _D =100mA
Dynamic					
C _{iss}	-	28	-	pF	V _{DS} =15V, V _{GS} =0V, f=1MHz
C _{oss}	-	14	-		
C _{rss}	-	4.2	-		
t _{d(ON)}	-	3	-	ns	V _{DS} =15V, I _D =0.5A, V _{GS} =10V, R _G =1Ω
t _r	-	15.4	-		
t _{d(OFF)}	-	10	-		
t _f	-	12	-		

Qg	-	1.7	-	nC	V _{DS} =15V, I _D =1A, V _{GS} =10V
Qgs	-	0.6	-		
Qgd	-	0.6	-		
Source-Drain Diode					
I _S	-	-	0.48	A	
I _{SM}	-	-	1.9		
*V _{SD}	-	0.78	1.2	V	V _{GS} =0V, I _S =0.1A
*trr	-	4.8	-	ns	I _F =0.5A, dI _F /dt=100A/μs
*Qrr	-	1.1	-	nC	

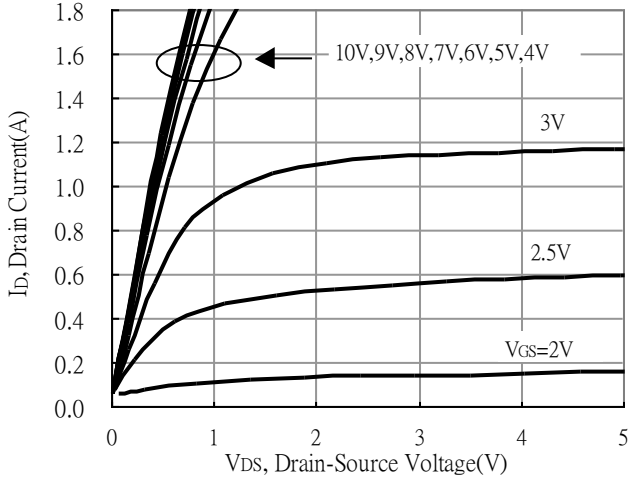
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Recommended Soldering Footprint

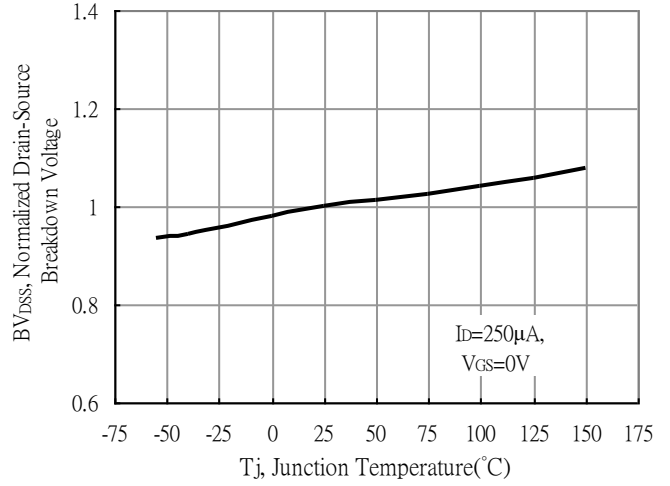


Typical Characteristics

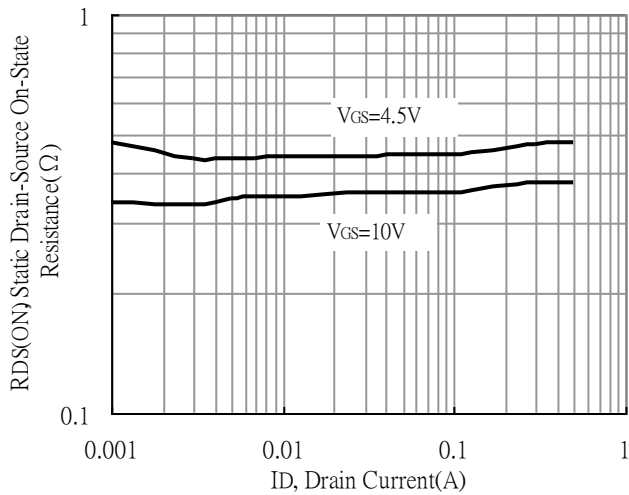
Typical Output Characteristics



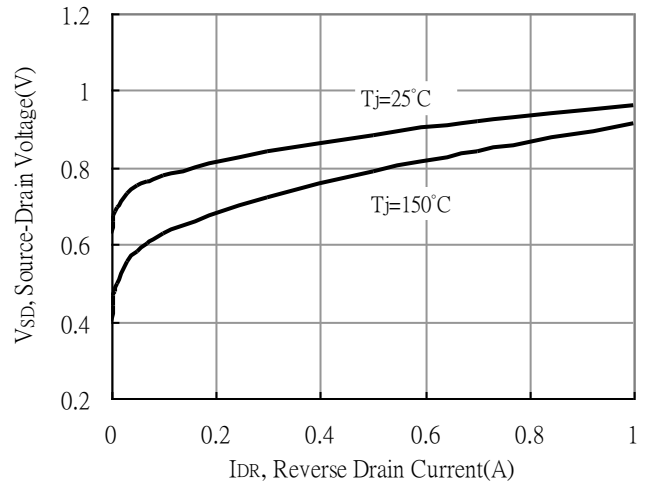
Brekdown Voltage vs Ambient Temperature



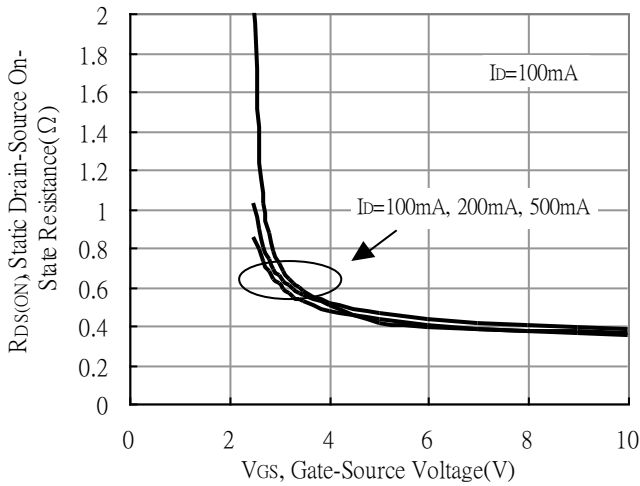
Static Drain-Source On-State resistance vs Drain Current



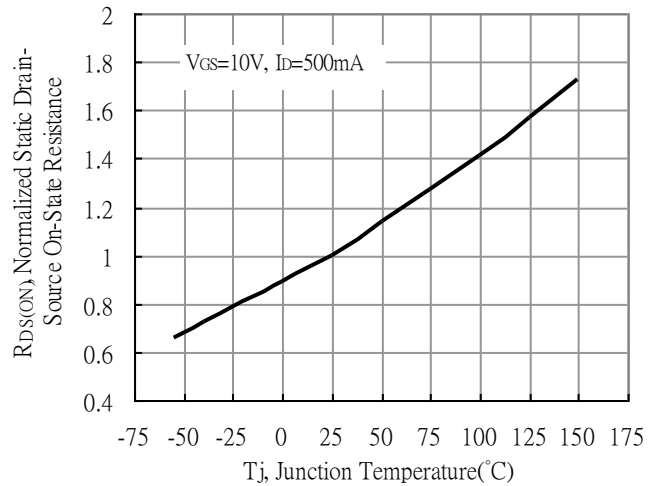
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

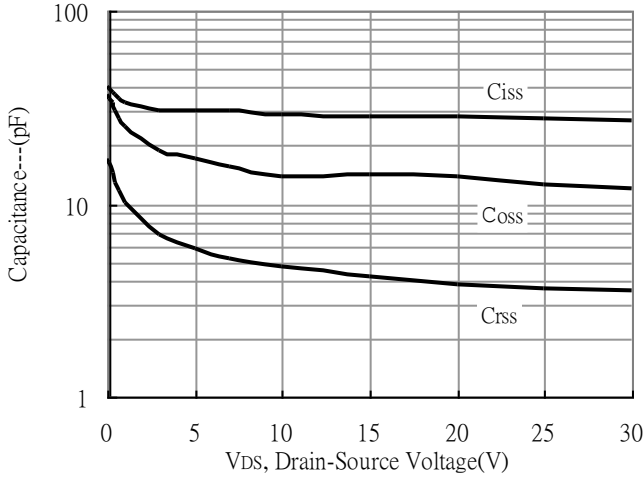


Drain-Source On-State Resistance vs Junction Temperature

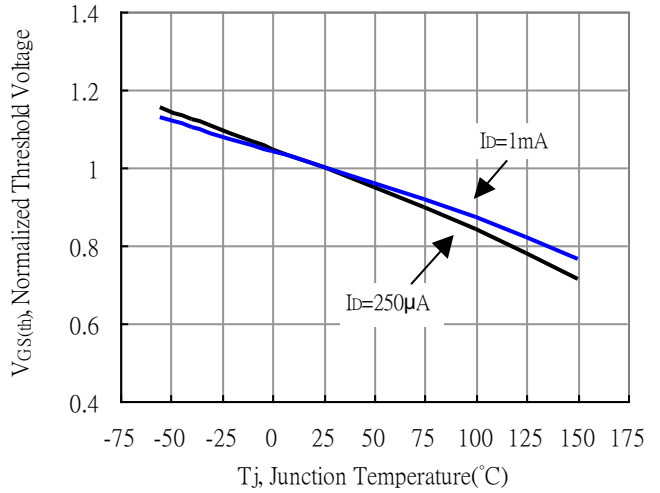


Typical Characteristics(Cont.)

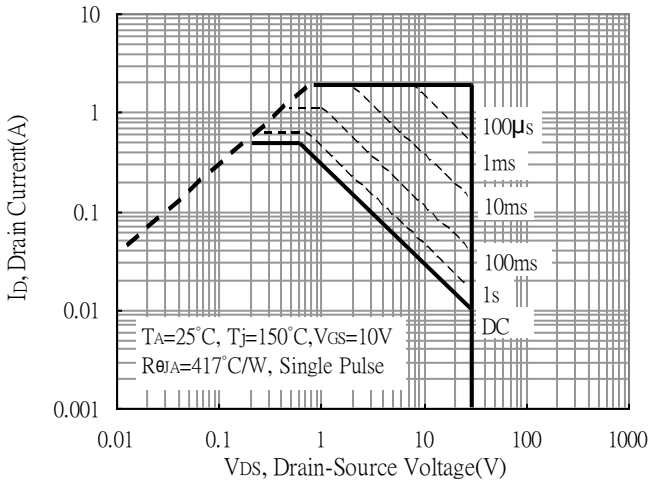
Capacitance vs Drain-to-Source Voltage



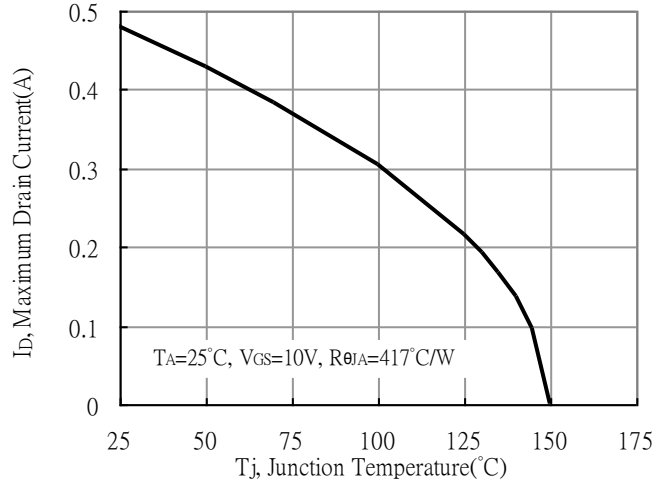
Threshold Voltage vs Junction Temperature



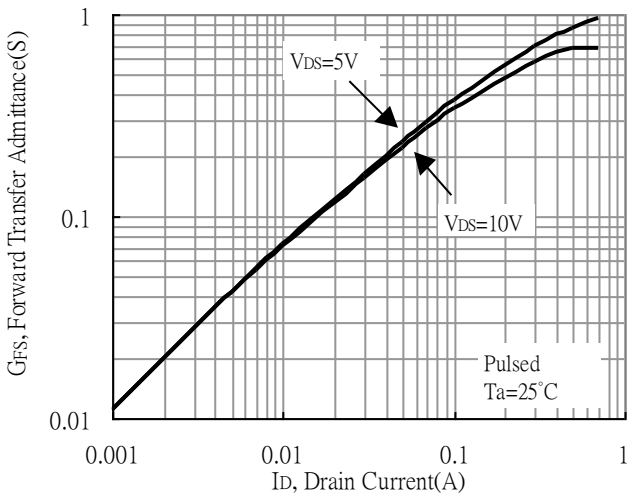
Maximum Safe Operating Area



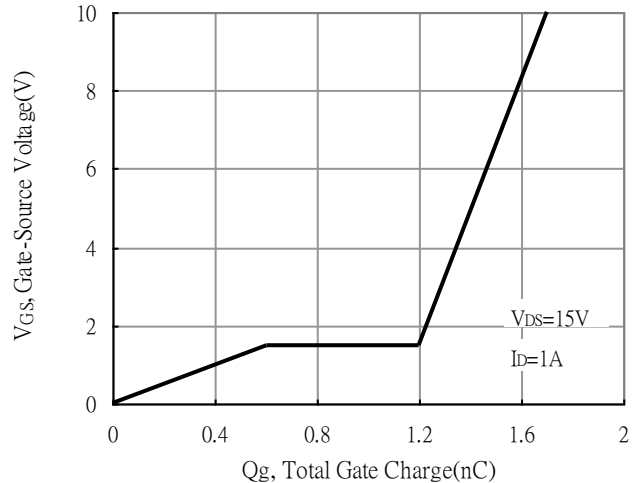
Maximum Drain Current vs Junction Temperature



Forward Transfer Admittance vs Drain Current

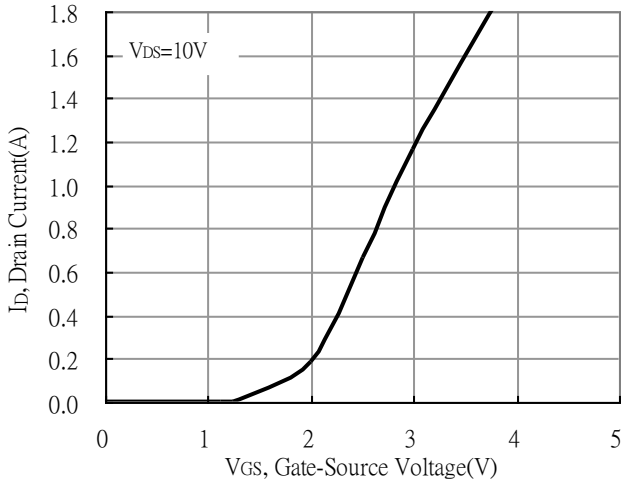


Gate Charge Characteristics

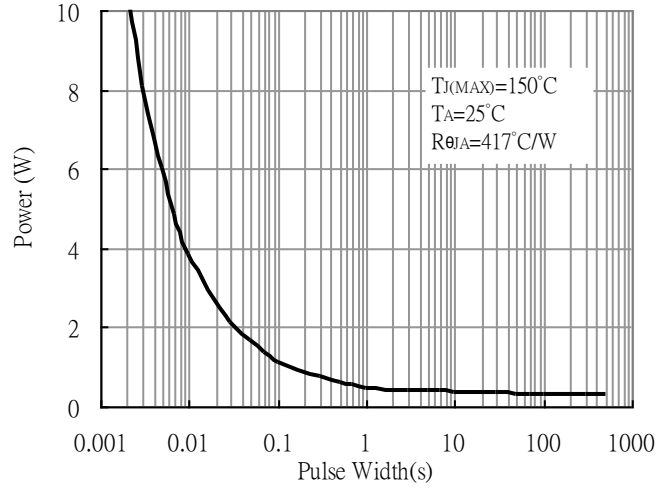


Typical Characteristics(Cont.)

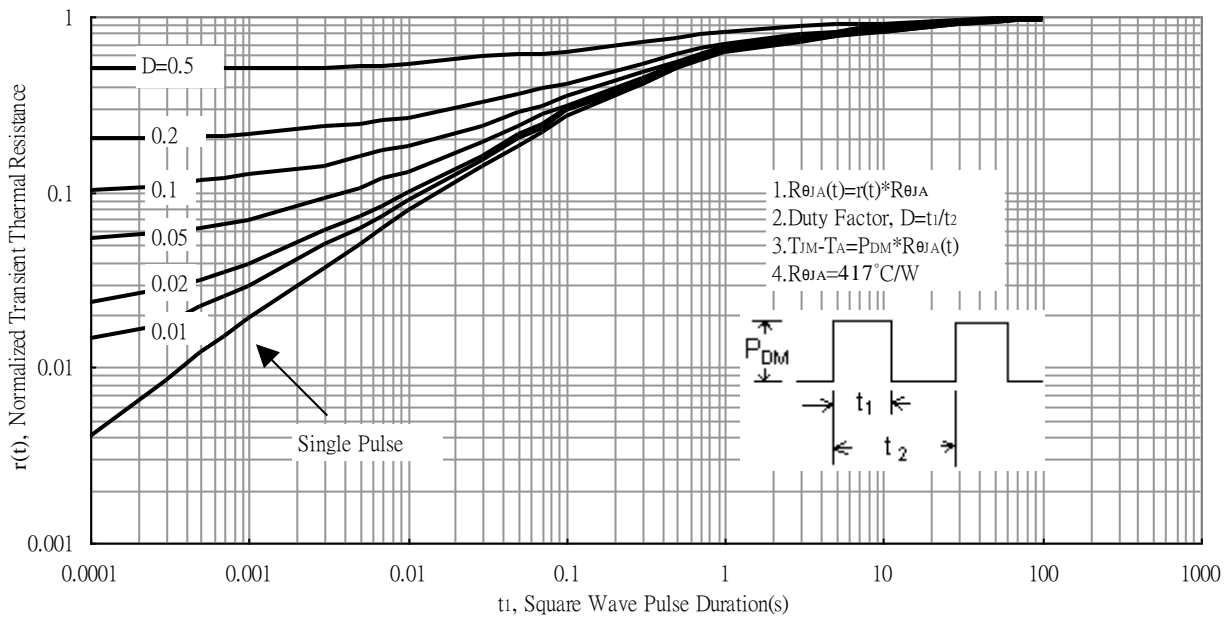
Typical Transfer Characteristics



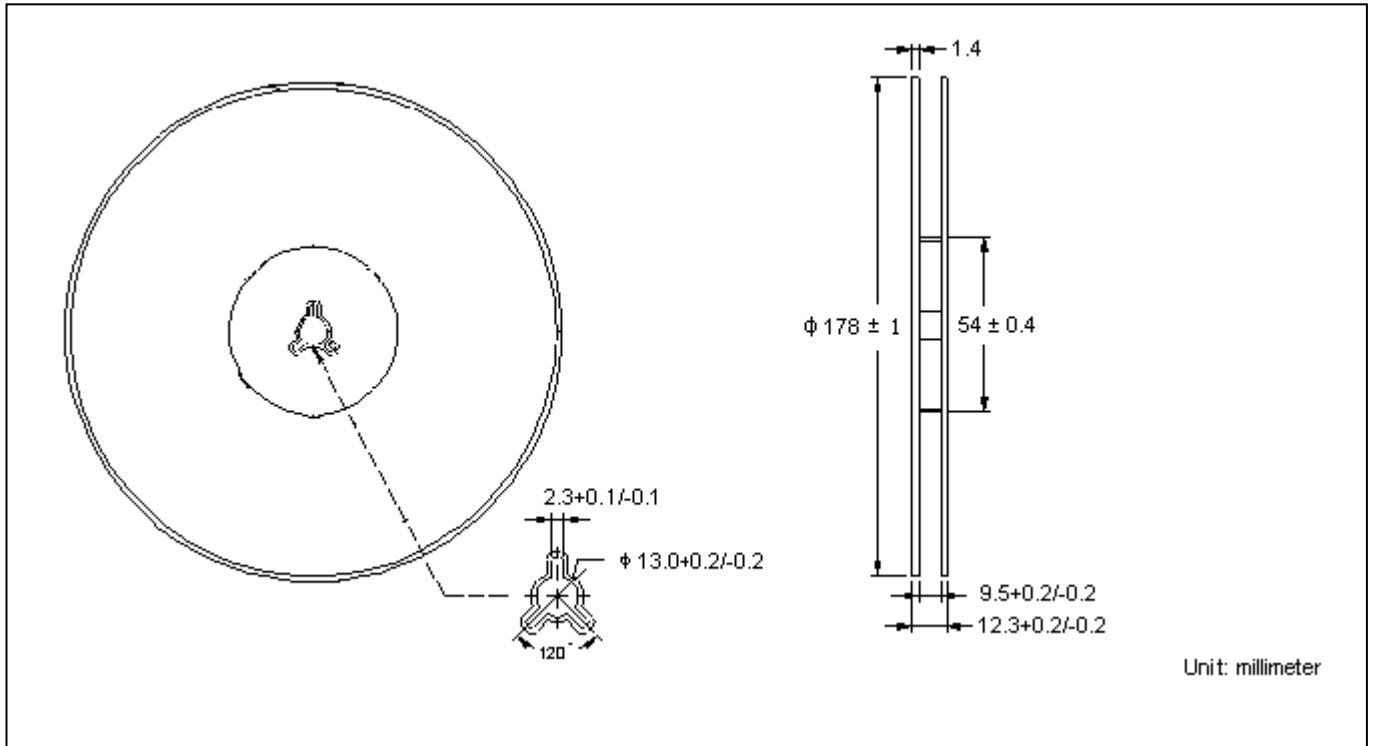
Single Pulse Maximum Power Dissipation, Junction to Ambient



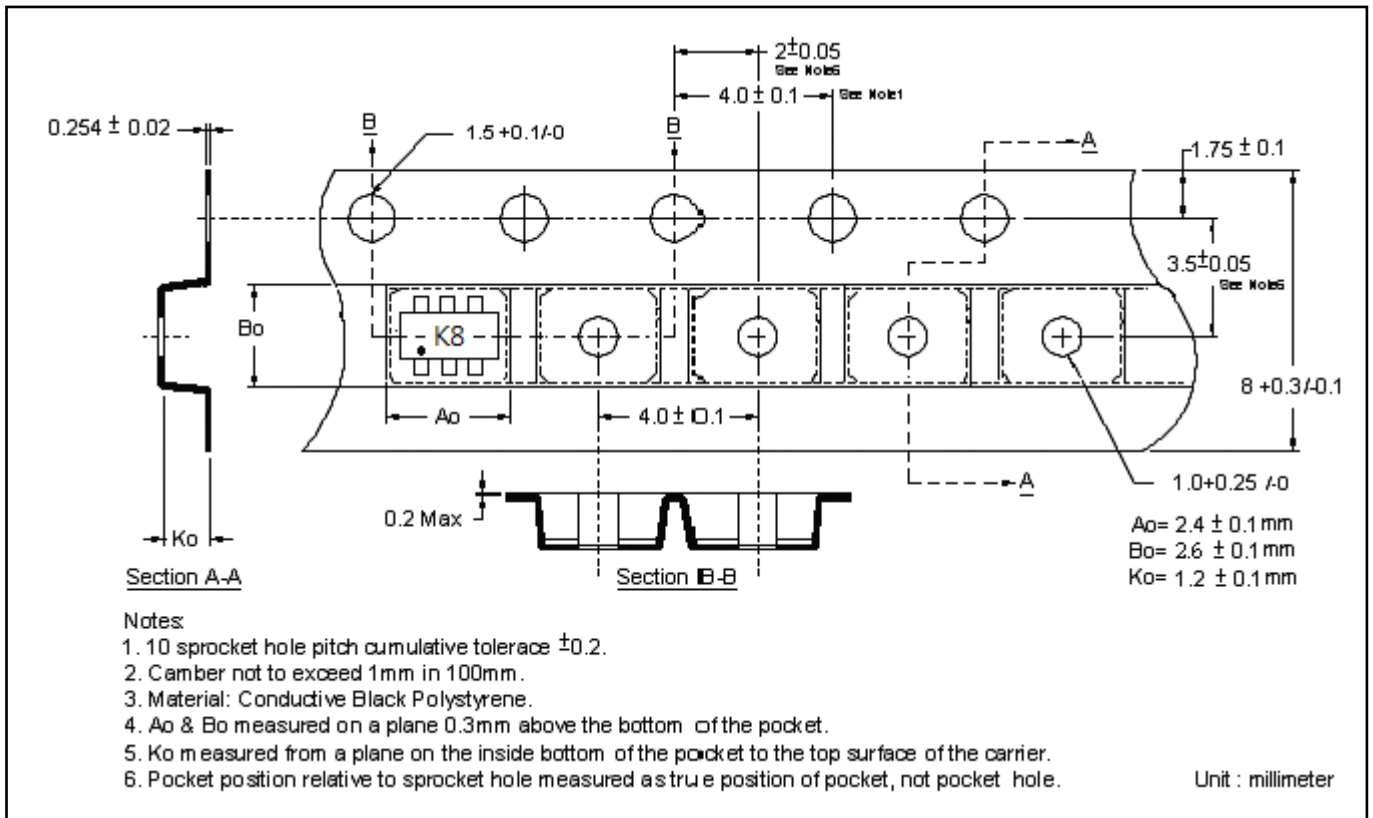
Transient Thermal Response Curves



Reel Dimension



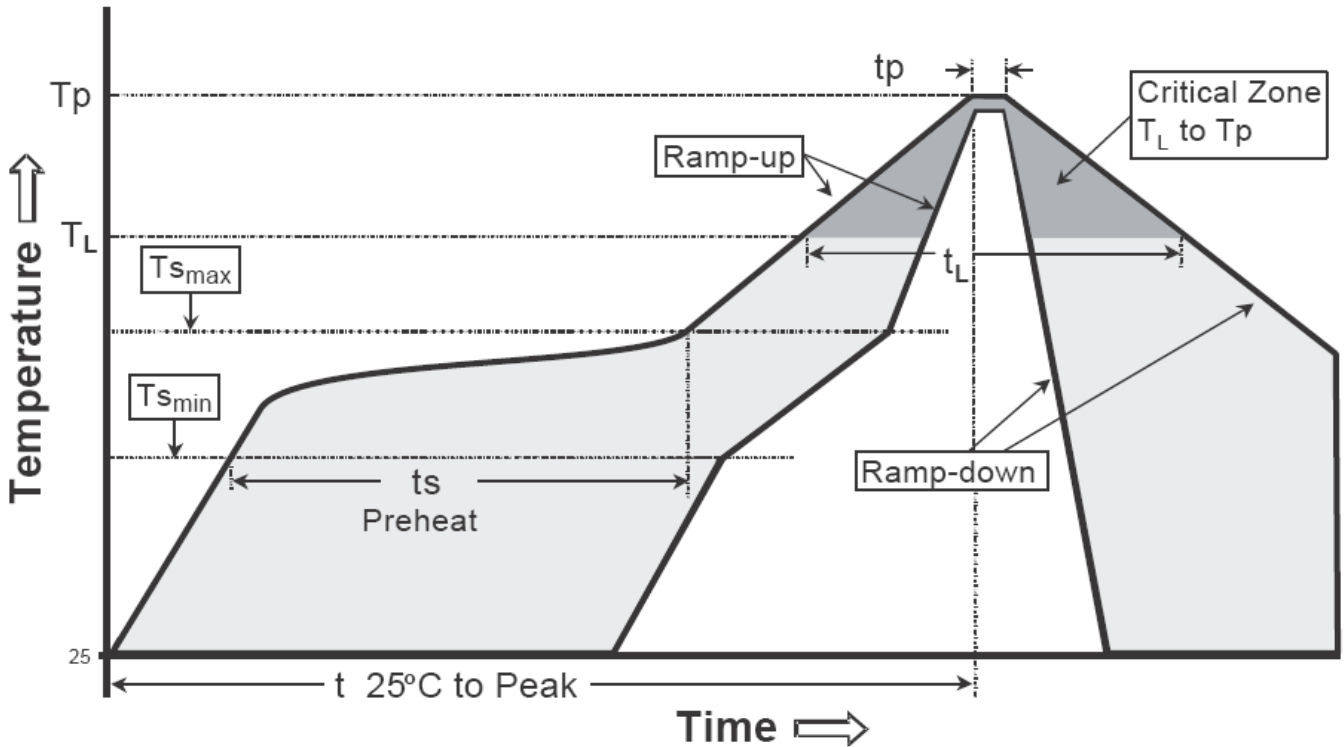
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

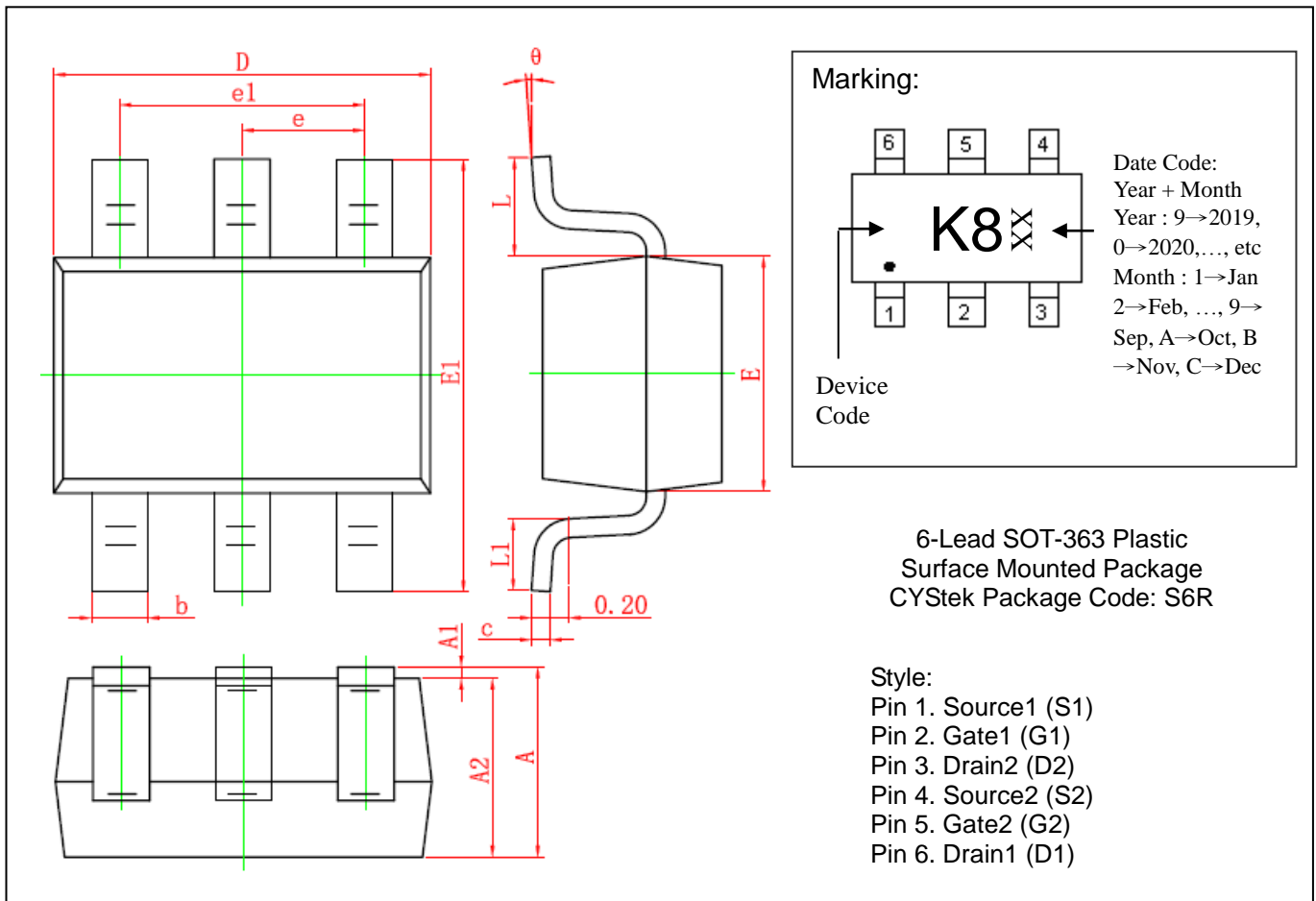
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOT-363 Dimension



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.100	0.035	0.043	E1	2.150	2.450	0.085	0.096
A1	0.000	0.100	0.000	0.004	e	0.650	TYP	0.026	TYP
A2	0.900	1.000	0.035	0.039	e1	1.200	1.400	0.047	0.055
b	0.150	0.350	0.006	0.014	L	0.525	REF	0.021	REF
c	0.080	0.150	0.003	0.006	L1	0.260	0.460	0.010	0.018
D	2.000	2.200	0.079	0.087	θ	0°	8°	0°	8°
E	1.150	1.350	0.045	0.053					

Notes : 1.Controlling dimension : millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material :

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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